Features

- Single-voltage Read/Write Operation: 2.7V to 3.6V (BV), 3.0V to 3.6V (LV)
- Fast Read Access Time 70 ns
- Internal Erase/Program Control
- Sector Architecture
 - One 8K Word (16K Bytes) Boot Block with Programming Lockout
 - Two 4K Word (8K Bytes) Parameter Blocks
 - One 112K Word (224K Bytes) Main Memory Array Block
- Fast Sector Erase Time 10 Seconds
- Byte-by-byte or Word-by-word Programming 30 μs Typical
- Hardware Data Protection
- Data Polling for End of Program Detection
- Low Power Dissipation
 - 25 mA Active Current
 - 50 µA CMOS Standby Current
- Typical 10,000 Write Cycles

Description

The AT49BV/LV2048A is a 3-volt, 2-megabit Flash memory organized as 262,144 words of 8 bits each or 128K words of 16 bits each. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 70 ns with power dissipation of just 67 mW at 2.7V read. When deselected, the CMOS standby current is less than 50 μ A.

The device contains a user-enabled "boot block" protection feature. The AT49BV/LV2048A locates the boot block at lowest order addresses ("bottom boot").

To allow for simple in-system reprogrammability, the AT49BV/LV2048A does not require high input voltages for programming. Reading data out of the device is similar to reading from an EPROM; it has standard \overline{CE} , \overline{OE} and \overline{WE} inputs to avoid bus contention. Reprogramming the AT49BV/LV2048A is performed by first erasing a block of data and then programming on a byte-by-byte or word-by-word basis.

Pin Configurations

Pin Name	Function
A0 - A16	Addresses
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
RESET	Reset
VPP	VPP can be left unconnected or connected to VCC, GND, 5V or 12V. The input has no effect on the operation of the device.
I/O0 - I/O15	Data Inputs/Outputs
I/O15(A-1)	I/O15 (Data Input/Output, Word Mode) A-1 (LSB Address Input, Byte Mode)
BYTE	Selects Byte or Word Mode
NC	No Connect



2-megabit (256K x 8/ 128K x 16) Single 2.7-volt *Battery-Voltage*[™] Flash Memory

AT49BV2048A AT49LV2048A

Rev. 1914D-FLASH-03/02





AT49BV/LV2048A TSOP Top View Type 1

A15 🖂 1 48 🗖 A16 A14 🗆 47 BYTE A13 46 GND 3 A12 🗆 45 I/O15/A-1 □ I/O7 A11 🗆 44 A10 🗆 6 43 ☐ I/O14 A9 🗀 7 42 1/06 41 ____ I/O13 A8 🖂 8 ____ I/O5 NC 🗆 9 40 NC 10 39 1/012 1/04 WE 11 38 RESET [12 37 VPP 🖂 13 36 ____ I/O11 NC 14 35 1/03 15 34 ____ I/O10 NC [16 33 ____ I/O2 NC 17 32 1/09 31 ☐ I/O1 A6 🖂 19 ____ I/O8 30 A5 🗖 20 29 1/00 ___ OE A4 🗆 21 28 A3 22 27 ___ GND A2 🗖 23 26 A1 🗆 25 🗖 A0 24

Note: "•" denotes a white dot on the package.

The device is erased by executing the Erase command sequence; the device internally controls the erase operation. The memory is divided into four blocks for erase operations. There are two 4K word parameter block sections, the boot block, and the main memory array block. The typical number of program and erase cycles is in excess of 10,000 cycles.

The 8K word boot block section includes a reprogramming lock out feature to provide data integrity. This feature is enabled by a command sequence. Once the boot block programming lockout feature is enabled, the data in the boot block cannot be changed when input levels of 5.5 volts or less are used. The boot sector is designed to contain user secure code.

The $\overline{\text{BYTE}}$ pin controls whether the device data I/O pins operate in the byte or word configuration. If the $\overline{\text{BYTE}}$ pin is set at a logic "1" or left open, the device is in word configuration, I/O0 - I/O15 are active and controlled by $\overline{\text{CE}}$ and $\overline{\text{OE}}$.

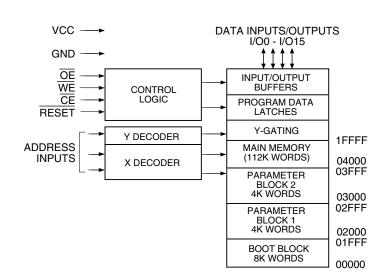
If the BYTE pin is set at logic "0", the device is in byte configuration, and only data I/O pins I/O0 - I/O7 are active and controlled by \overline{CE} and \overline{OE} . The data I/O pins I/O8 - I/O14 are tristated and the I/O15 pin is used as an input for the LSB (A-1) address function.

AT49BV/LV2048A SOIC (SOP)

VPP 🖂	1	44	RESET
NC 🖂	2	43	- WE
NC 🖂	3	42	A8
A7 🗔	4	41	🗆 A9
A6 🗔	5	40	🗖 A10
A5 🗔	6	39	A11
A4 🗔	7	38	🗆 A12
A3 🗔	8	37	A13
A2 🗔	9	36	🗆 A14
A1 🗔	10	35	A15
A0 🗀	11	34	🗆 A16
CE 🖂	12	33	BYTE
GND 🖂	13	32	🔤 GND
OE 🖂	14	31	I/O15/A-1
I/O0 🗀	15	30	I/O7
I/O8 🗔	16	29	□ I/O14
I/O1 🗔	17	28	I/O6
I/O9 🗀	18	27	I/O13
I/O2 🗔	19	26	☐ I/O5
I/O10 🗀	20	25	I/O12
I/O3 🗔	21	24	□ I/O4
I/O11 🗔	22	23	□ vcc

AT49BV/LV2048A

AT49BV/LV2048 A Block Diagram



Device Operation

READ: The AT49BV/LV2048A is accessed like an EPROM. When \overline{CE} and \overline{OE} are low and \overline{WE} is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in the high-impedance state whenever \overline{CE} or \overline{OE} is high. This dual-line control gives designers flexibility in preventing bus contention.

COMMAND SEQUENCES: When the device is first powered on it will be reset to the read or standby mode, depending upon the state of the control line inputs. In order to perform other device functions, a series of command sequences are entered into the device. The command sequences are shown in the Command Definitions table (I/O8 - I/O15 are don't care inputs for the command codes). The command sequences are written by applying a low pulse on the WE or CE input with CE or WE low (respectively) and OE high. The address is latched on the falling edge of \overline{CE} or \overline{WE} , whichever occurs last. The data is latched by the first rising edge of \overline{CE} or \overline{WE} . Standard microprocessor write timings are used. The address locations used in the command sequences are not affected by entering the command sequences.

RESET: A RESET input pin is provided to ease some system applications. When RESET is at a logic high level, the device is in its standard operating mode. A low level on the RESET input halts the present device operation and puts the outputs of the device in a high-impedance state. When a high level is reasserted on the RESET pin, the device returns to the read or standby mode, depending upon the state of the control inputs. By applying a 12V <Symbol 10pt> \pm 0.5V input signal to the RESET pin the boot block array can be reprogrammed even if the boot block program lockout feature has been enabled (see "Boot Block Programming Lockout Override" section).

ERASURE: Before a byte or word can be reprogrammed, it must be erased. The erased state of memory bits is a logic "1". The entire device can be erased by using the Chip Erase command or individual sectors can be erased by using the Sector Erase commands.

CHIP ERASE: The entire device can be erased at one time by using the 6-byte chip erase software code. After the chip erase has been initiated, the device will internally time the erase operation so that no external clocks are required. The maximum time to erase the chip is t_{FC} .

If the boot block lockout has been enabled, the chip erase will not erase the data in the boot block; it will erase the main memory block and the parameter blocks only. After the chip erase, the device will return to the read or standby mode.





SECTOR ERASE: As an alternative to a full chip erase, the device is organized into four sectors that can be individually erased. There are two 4K word parameter block sections, one boot block, and the main memory array block. The Sector Erase command is a six-bus cycle operation. The sector address is latched on the falling \overline{WE} edge of the sixth cycle while the 30H data input command is latched at the rising edge of \overline{WE} . The sector erase starts after the rising edge of \overline{WE} of the sixth cycle. The erase operation is internally controlled; it will automatically time to completion. Whenever the main memory block is erased and reprogrammed, the two parameter blocks should be erased and reprogrammed before the main memory block is erased again. Whenever a parameter block is erased and reprogrammed, the other parameter block should be erased and reprogrammed, the main memory block and the parameter blocks should be erased and reprogrammed, the main memory block is erased again.

BYTE/WORD PROGRAMMING: Once a memory block is erased, it is programmed (to a logic "0") on a byte-by-byte or word-by-word basis. Programming is accomplished via the internal device command register and is a four-bus cycle operation. The device will automatically generate the required internal program pulses.

Any commands written to the chip during the embedded programming cycle will be ignored. If a hardware reset happens during programming, the data at the location being programmed will be corrupted. Please note that a data "0" cannot be programmed back to a "1"; only erase operations can convert "0"s to "1"s. Programming is completed after the specified t_{BP} cycle time. The Data Polling feature may also be used to indicate the end of a program cycle.

BOOT BLOCK PROGRAMMING LOCKOUT: The device has one designated block that has a programming lockout feature. This feature prevents programming of data in the designated block once the feature has been enabled. The size of the block is 8K words. This block, referred to as the boot block, can contain secure code that is used to bring up the system. Enabling the lockout feature will allow the boot code to stay in the device while data in the rest of the device is updated. This feature does not have to be activated; the boot block's usage as a write-protected region is optional to the user. The address range of the boot block is 00000H to 01FFFH.

Once the feature is enabled, the data in the boot block can no longer be erased or programmed when input levels of 5.5V or less are used. Data in the main memory block can still be changed through the regular programming method. To activate the lockout feature, a series of six program commands to specific addresses with specific data must be performed. Please refer to the Command Definitions table.

BOOT BLOCK LOCKOUT DETECTION: A software method is available to determine if programming of the boot block section is locked out. When the device is in the software product identification mode (see Software Product Identification Entry and Exit sections) a read from the following address location will show if programming the boot block is locked out – 00002H. If the data on I/O0 is low, the boot block can be programmed; if the data on I/O0 is high, the program lockout feature has been enabled and the block cannot be programmed. The software product identification exit code should be used to return to standard operation.

BOOT BLOCK PROGRAMMING LOCKOUT OVERRIDE: The user can override the boot block programming lockout by taking the RESET pin to 12 volts during the entire chip erase, sector erase or word programming operation. When the RESET pin is brought back to TTL levels the boot block programming lockout feature is again active.

AT49BV/LV2048A

PRODUCT IDENTIFICATION: The product identification mode identifies the device and manufacturer as Atmel. It may be accessed by hardware or software operation. The hardware operation mode can be used by an external programmer to identify the correct programming algorithm for the Atmel product.

For details, see "Operating Modes" (for hardware operation) or "Software Product Identification Entry/Exit" on page 13. The manufacturer and device codes are the same for both modes.

DATA POLLING: The AT49BV/LV2048A features Data Polling to indicate the end of a program cycle. During a program cycle an attempted read of the last byte loaded will result in the complement of the loaded data on I/O7. Once the program cycle has been completed, true data is valid on all outputs and the next cycle may begin. During a chip or sector erase operation, an attempt to read the device will give a "0" on I/O7. Once the program or erase cycle has completed, true data will be read from the device. Data Polling may begin at any time during the program cycle.

TOGGLE BIT: In addition to Data Polling, the AT49BV/LV2048A provides another method for determining the end of a program or erase cycle. During a program or erase operation, successive attempts to read data from the device will result in I/O6 toggling between one and zero. Once the program cycle has completed, I/O6 will stop toggling and valid data will be read. Examining the toggle bit may begin at any time during a program cycle.

HARDWARE DATA PROTECTION: Hardware features protect against inadvertent programs to the AT49BV/LV2048A in the following ways: (a) V_{CC} sense: if V_{CC} is below 1.8V (typical), the program function is inhibited. (b) V_{CC} power on delay: once V_{CC} has reached the V_{CC} sense level, the device will automatically time out 10 ms (typical) before programming. (c) Program inhibit: holding any one of \overline{OE} low, \overline{CE} high or \overline{WE} high inhibits program cycles. (d) Noise filter: pulses of less than 15 ns (typical) on the \overline{WE} or \overline{CE} inputs will not initiate a program cycle.

INPUT LEVELS: While operating with a 2.7V to 3.6V power supply, the address and control inputs (\overline{OE} , \overline{CE} and \overline{WE}) may be driven from 0 to 5.5V without adversely affecting the operation of the device. The I/O lines can only be driven from 0 to V_{CC} + 0.6V.



AMEL

Command Definition (in Hex)⁽¹⁾

Command	Bus	1st Cy	Bus cle	2nd Cyd		3rd Cy		4th Cy		5th Cy		6th Cy	
Sequence	Cycles	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data
Read	1	Addr	D _{OUT}										
Chip Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	10
Sector Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	SA ⁽⁴⁾	30
Byte/Word Program	4	5555	AA	2AAA	55	5555	A0	Addr	D _{IN}				
Boot Block Lockout ⁽²⁾	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	40
Product ID Entry	3	5555	AA	2AAA	55	5555	90						
Product ID Exit ⁽³⁾	3	5555	AA	2AAA	55	5555	F0						
Product ID Exit ⁽³⁾	1	xxxx	F0										

Notes: 1. The DATA FORMAT in each bus cycle is as follows: I/O15 - I/O8 (Don't Care); I/O7 - I/O0 (Hex).

The ADDRESS FORMAT in each bus cycle is as follows: A15 - A0 (Hex), A-1, and A15 - A16 (Don't Care).

2. The boot sector has the address range 00000H to 01FFFH.

3. Either one of the Product ID Exit commands can be used.

4. SA = sector addresses: (A16 - A0)

SA = 01XXX for BOOT BLOCK

SA = 02XXX for PARAMETER BLOCK 1

SA = 03XXX for PARAMETER BLOCK 2

SA = 1FXXX for MAIN MEMORY ARRAY

Absolute Maximum Ratings*

Temperature under Bias55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including NC Pins) with Respect to Ground
All Output Voltages with Respect to Ground0.6V to V _{CC} + 0.6V
Voltage on RESET with Respect to Ground0.6V to +13.5V

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

AT49BV/LV2048A

DC and AC Operating Range

		AT49LV2048A-70	AT49BV2048A-90	AT49BV2048A-12
Operating	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C
Temperature (Case)	Ind.	N/A	-40°C - 85°C	-40°C - 85°C
V _{CC} Power Supply		3.0V - 3.6V	2.7V - 3.6V	2.7V - 3.6V

Operating Modes

Mode	CE	ŌĒ	WE	RESET	Ai	I/O
Read	V _{IL}	V _{IL}	V _{IH}	V _{IH}	Ai	D _{OUT}
Program/Erase ⁽²⁾	V _{IL}	V _{IH}	V _{IL}	V _{IH}	Ai	D _{IN}
Standby/Program Inhibit	V _{IH}	X ⁽¹⁾	х	V _{IH}	х	High-Z
Program Inhibit	Х	х	V _{IH}	V _{IH}		
	Х	V _{IL}	х	V _{IH}		
Output Disable	Х	V _{IH}	х	V _{IH}		High-Z
Reset	х	х	х	V _{IL}	Х	High-Z
Product Identification						
Hardware					A1 - A16 = V_{IL} , A9 = $V_{H}^{(3)}$ A0 = V_{IL}	Manufacturer Code ⁽⁴⁾
	V _{IL}	V _{IL}	V _{IH}	V _{IH}	A1 - A16 = V_{IL} , A9 = $V_{H}^{(3)}$ A0 = V_{IH}	Device Code ⁽⁴⁾
Software ⁽⁵⁾					A0 = V _{IL} , A1 - A16 = V _{IL}	Manufacturer Code ⁽⁴⁾
				V _{IH}	A0 = V _{IH} , A1 - A16 = V _{IL}	Device Code ⁽⁴⁾

Notes: 1. X can be V_{IL} or V_{IH}. 2. Refer to AC programming waveforms.

3. $V_{\rm H} = 12.0V < \text{Symbol 10pt} > \pm 0.5V.$

4. Manufacturer Code: 001FH

Device Code: 0082H

5. See details under "Software Product Identification Entry/Exit" on page 13.

DC Characteristics

Symbol	Parameter	Condition	Min	Мах	Units
ILI	Input Load Current	$V_{IN} = 0V$ to V_{CC}		10.0	μA
I _{LO}	Output Leakage Current	$V_{I/O} = 0V$ to V_{CC}		10.0	μA
I _{SB1}	V _{CC} Standby Current CMOS	$\overline{\text{CE}} = \text{V}_{\text{CC}} - 0.3 \text{V}$ to V_{CC}		50.0	μA
I _{SB2}	V _{CC} Standby Current TTL	$\overline{CE} = 2.0V$ to V_{CC}		0.5	mA
I _{CC} ⁽¹⁾	V _{CC} Active Current	$f = 5 \text{ MHz}; I_{OUT} = 0 \text{ mA}$		25.0	mA
V _{IL}	Input Low Voltage			0.6	V
V _{IH}	Input High Voltage		2.0		V
V _{OL}	Output Low Voltage	I _{OL} = 2.1 mA		0.45	V
V _{OH}	Output High Voltage	I _{OH} = -400 μA	2.4		V

Note: In the erase mode, I_{CC} is 50 mA.

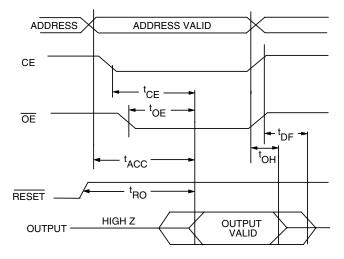




AC Read Characteristics

		AT49LV2048A-70		AT49BV2048A-90		AT49BV2048A-12		
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Units
t _{ACC}	Address to Output Delay		70		90		120	ns
t _{CE} ⁽¹⁾	CE to Output Delay		70		90		120	ns
t _{OE} ⁽²⁾	OE to Output Delay	0	35	0	40	0	50	ns
t _{DF} ⁽³⁾⁽⁴⁾	CE or OE to Output Float	0	25	0	25	0	30	ns
t _{OH}	Output Hold from OE, CE or Address, whichever occurred first	0		0		0		ns
t _{RO}	RESET to Output Delay		800		800		800	ns

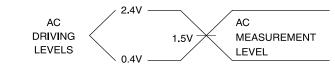
AC Read Waveforms⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾



- Notes: 1. \overline{CE} may be delayed up to $t_{ACC} t_{CE}$ after the address transition without impact on t_{ACC} . 2. \overline{OE} may be delayed up to $t_{CE} t_{OE}$ after the falling edge of \overline{CE} without impact on t_{CE} or by $t_{ACC} t_{OE}$ after an address change without impact on t_{ACC}.
 t_{DF} is specified from OE or CE, whichever occurs first (C_L = 5 pF).
 This parameter is characterized and is not 100% tested.

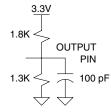
AT49BV/LV2048A

Input Test Waveforms and Measurement Level



t_R, t_F < 5 ns

Output Test Load



Pin Capacitance

f = 1 MHz, T = $25^{\circ}C^{(1)}$

Symbol	Тур	Мах	Units	Conditions
C _{IN}	4	6	pF	$V_{IN} = 0V$
C _{OUT}	8	12	pF	$V_{OUT} = 0V$

Note: This parameter is characterized and is not 100% tested.



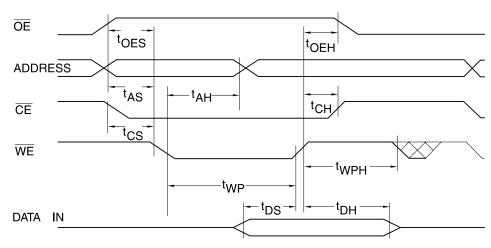


AC Word Load Characteristics

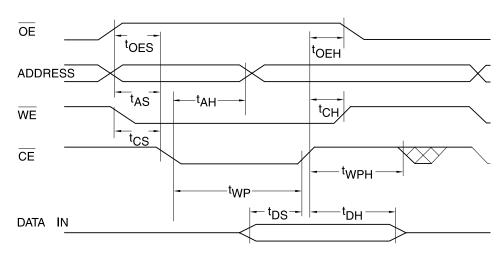
Symbol	Parameter	Min	Мах	Units
t _{AS} , t _{OES}	Address, OE Setup Time	0		ns
t _{AH}	Address Hold Time	70		ns
t _{cs}	Chip Select Setup Time	0		ns
t _{CH}	Chip Select Hold Time	0		ns
t _{wP}	Write Pulse Width (\overline{WE} or \overline{CE})	70		ns
t _{DS}	Data Setup Time	70		ns
t _{DH} , t _{OEH}	Data, OE Hold Time	0		ns
t _{WPH}	Write Pulse Width High	50		ns

AC Byte/Word Load Waveforms

WE Controlled



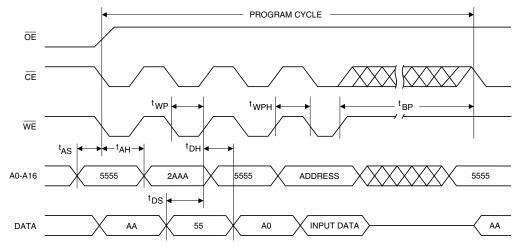
CE Controlled



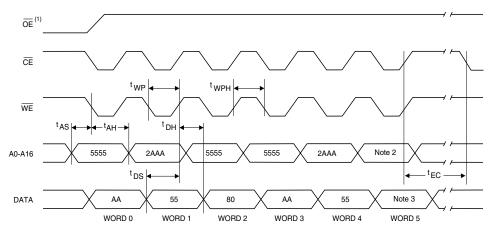
Program Cycle Characteristics

Symbol	Parameter	Min	Тур	Max	Units
t _{BP}	Byte/Word Programming Time		30		μs
t _{AS}	Address Setup Time	0			ns
t _{AH}	Address Hold Time	70			ns
t _{DS}	Data Setup Time	70			ns
t _{DH}	Data Hold Time	0			ns
t _{WP}	Write Pulse Width	70			ns
t _{wPH}	Write Pulse Width High	50			ns
t _{EC}	Erase Cycle Time			10	seconds

Program Cycle Waveforms



Sector or Chip Erase Cycle Waveforms



- Notes: 1. \overline{OE} must be high only when \overline{WE} and \overline{CE} are both low.
 - 2. For chip erase, the address should be 5555. For sector erase, the address depends on what sector is to be erased. (See note 4 under Command Definitions.)
 - 3. For chip erase, the data should be 10H, and for sector erase, the data should be 30H.





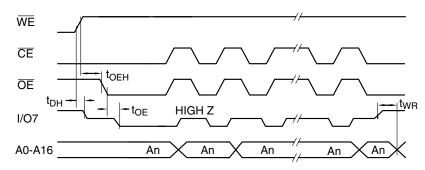
Data Polling Characteristics⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	10			ns
t _{OEH}	OE Hold Time	10			ns
t _{OE}	OE to Output Delay ⁽²⁾				ns
t _{wR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See t_{OE} spec in "AC Read Characteristics" on page 8.

Data Polling Waveforms



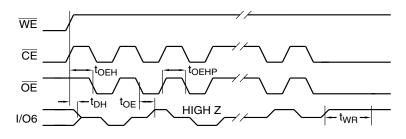
Toggle Bit Characteristics⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	10			ns
t _{OEH}	OE Hold Time	10			ns
t _{OE}	OE to Output Delay ⁽²⁾				ns
t _{OEHP}	OE High Pulse	150			ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

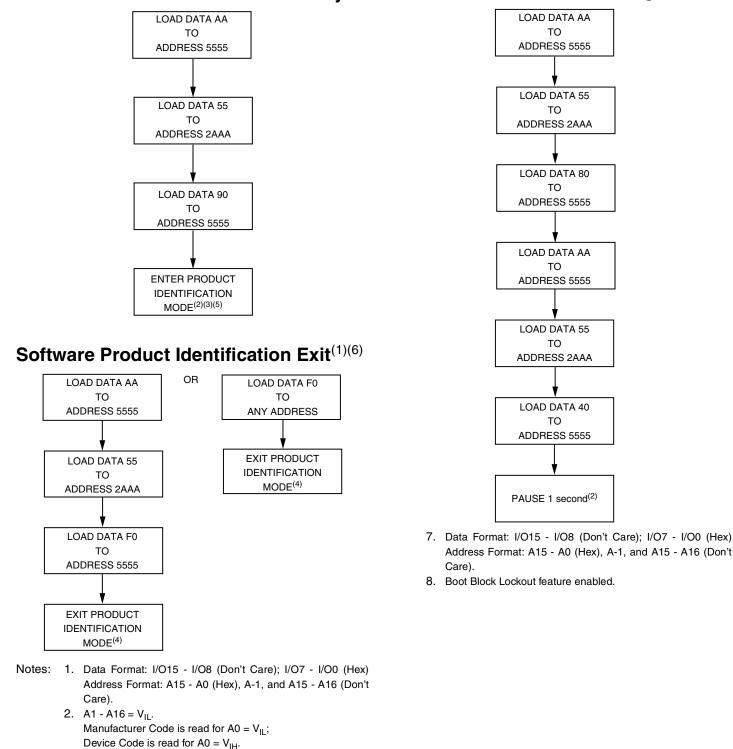
2. See t_{OE} spec in "AC Read Characteristics" on page 8.

Toggle Bit Waveforms⁽¹⁾⁽²⁾⁽³⁾



- Notes: 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit. The t_{OEHP} specification must be met by the toggling input(s).
 - 2. Beginning and ending state of I/O6 will vary.
 - 3. Any address location may be used but the address should not vary.

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Software Product Identification Entry⁽¹⁾ Boot Block Lockout Enable Algorithm⁽¹⁾

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5. Manufacturer Code: 001FH Device Code: 0082H

down.

3. The device does not remain in identification mode if powered

6. Either one of the Product ID Exit commands can be used.

4. The device returns to standard operation mode.



Ordering Information

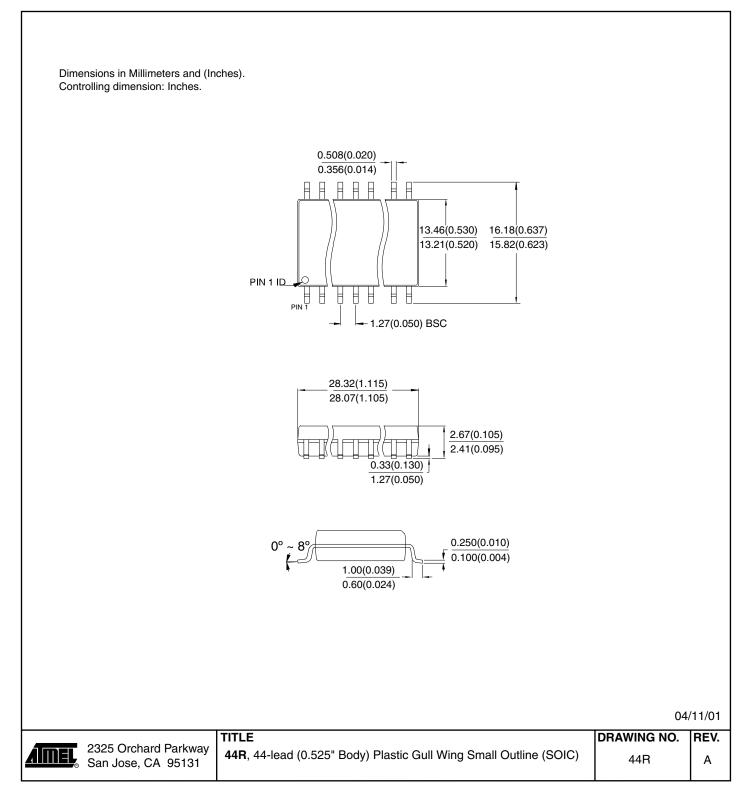
t _{ACC}	I _{CC} (mA)					
(ns)	Active	Standby	Ordering Code	Package	Operation Range	
70	25	0.05	AT49LV2048A-70RC AT49LV2048A-70TC	44R 48T	Commercial (0° to 70°C)	
90	25	0.05	AT49BV2048A-90TC	48T	Commercial (0° to 70°C)	
			AT49BV2048A-90TI	48T	Industrial (-40° to 85°C)	
120	25	0.05	AT49BV2048A-12TC	48T	Commercial (0° to 70°C)	
			AT49BV2048A-12TI	48T	Industrial (-40° to 85°C)	

Package Type			
44R	44-lead, 0.525" Wide, Plastic Gull Wing Small Outline (SOIC)		
48T	48-lead, 12 x 20 mm, Plastic Thin Small Outline Package (TSOP)		

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Packaging Information

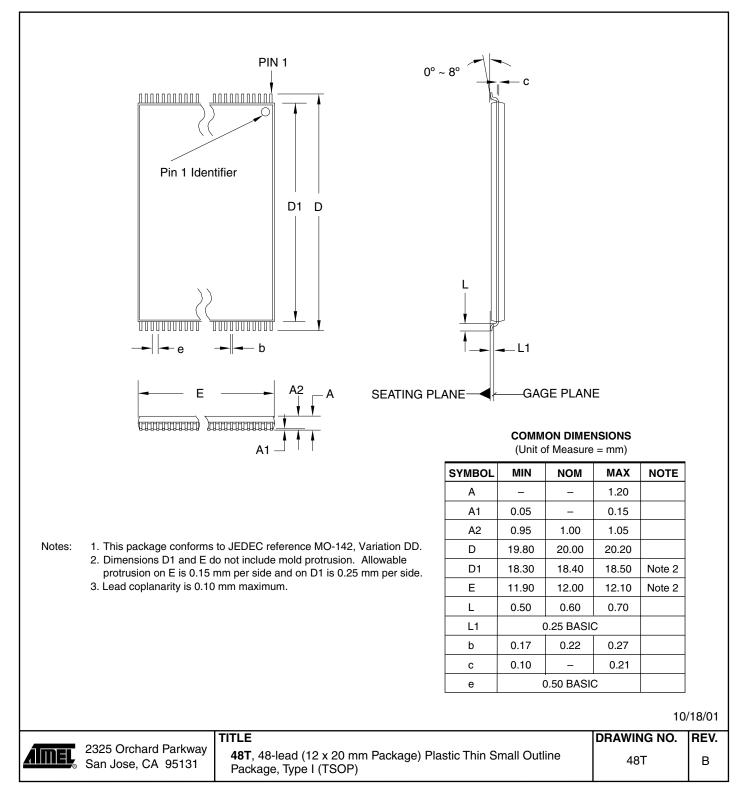
44R - SOIC







48T – TSOP





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